

IN THE U.S. PATENT AND TRADEMARK OFFICE

Applicant:

CHEN, Shun-An et al.

Conf.:

1826

Appl. No.:

09/930,971

Group:

2863

Filed:

August 17, 2001

Examiner: Xiuquin Sun

For:

A SYSTEM FOR DYNAMICALLY MONITORING THE

STABILITY OF SEMICONDUCTOR MANUFACTURING EQUIPMENT

## REPLY UNDER 37 C.F.R. § 1.111

Assistant Commissioner for Patents Washington, DC 20231

July 3, 2002

0941-03

Sir:

Responsive to the April 3, 2002 Office Action, the following amendments and remarks are respectfully submitted in connection with the above-identified application.

## IN THE ABSTRACT OF THE DISCLOSURE:

Please replace the Abstract of the Disclosure with the rewritten Abstract of the Disclosure located below:

## --ABSTRACT OF THE DISCLOSURE

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A system for dynamically monitoring the stability of manufacturing equipment including a process executor requesting a plurality of semi-manufactured products processed by the manufacturing equipment to be inspected at a first sampling rate